Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination

10/653,838 Examiner

CHANG ET AL. Art Unit

Sheela C. Chawan

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SEARCHED			
Class	Subclass	Date	Examiner
382	141	12/7/2006	scc
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356	28,623	12/7/2006	,
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST,US- PGPUB,USPAT,EPO,JPO,DERWENT ,IBM-TDB	12/7/2006	scc	
INVENTOR NAME SEARCH	12/7/2006	n	